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| Notice of References Cited | Application/Control No. 10/658,292 | Applicant(s)/Patent Under Reexamination TAGAWA, YOJIRO | |
| | Examiner Hung H. Lam | Art Unit 2622 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-7,010,144 | 03-2006 | Davis et al. | 382/100 |
| * | B | US-2002/0113757 | 08-2002 | Hoisko, Jyrki | 345/8 |
| * | C | US-6,947,954 | 09-2005 | Cohen et al. | 707/104.1 |
| * | D | US-2003/0154178 | 08-2003 | McIntyre et al. | 707/1 |
| * | E | US-2003/0005464 | 01-2003 | Gropper et al. | 725/115 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
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